

Search Notes

Application/Control No.

10/796,542

Examiner

David Sample

Applicant(s)/Patent under
Reexamination

TAKEWAKI ET AL.

Art Unit

1755

SEARCHED

Class	Subclass	Date	Examiner
423	Dig.27	4/12/2005	<i>[Signature]</i>
423	700	4/12/2005	<i>[Signature]</i>
210	691	4/12/2005	<i>[Signature]</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
SAME AS ABOVE		4/12/2005	<i>[Signature]</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name search	4/12/2005	<i>[Signature]</i>
Parent applications reviewed included prior art cited therein	4/12/2005	<i>[Signature]</i>